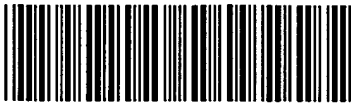


**Search Notes**

Application/Control No.

10/530,470

Examiner

John Kim

Applicant(s)/Patent under  
Reexamination

IKEDA ET AL.

Art Unit

1723

**SEARCHED**

Class	Subclass	Date	Examiner
210	232, 321.79, 321.8, 321.81	4/25/2006	JK
	321.88		
	321.89		
	321.9		
	323.2		
	503, 504		

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Inventor Name Search	4/25/2006	JK
EAST Search Note	4/25/2006	JK